

## Description

Passivated, sensitive gate triacs in a plastic envelope, intended for use in general purpose bidirectional switching and phase control applications, where high sensitivity is required in all four quadrants.

## Features

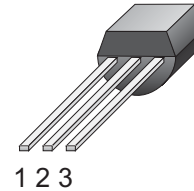
- Blocking voltage to 600 V
- On-state RMS current to 1 A

## Applications

- Motor control
- Industrial and domestic lighting
- Heating
- Static switching

## Simplified outline

### TO-92



### Symbol



Pin	Description
1	Main terminal 1 (T1)
2	Main terminal 2 (T2)
3	gate (G)
TAB	Main terminal

SYMBOL	PARAMETER	Value	Unit
$V_{DRM}$	Repetitive peak off-state voltages Z0103MAG Z0103NAG	600 800	V
$I_{T(RMS)}$	RMS on-state current	1	A
$I_{TSM}$	Non-repetitive peak on-state current	8	A

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	Value	UNIT
$R_{th(j-l)}$	Junction to lead (AC)	-	-	-	60	$^{\circ}C/W$
$R_{th j-a}$	Junction to ambient	-	-	-	150	$^{\circ}C/W$

**Limiting values in accordance with the Maximum system(IEC 134)**

SYMBOL	PARAMETER	CONDITIONS			MIN	Value	UNIT
$V_{DSM}/V_{RSM}$		Z0103MAG Z0103NAG			-	600 800	V
$I_{T(RMS)}$	RMS on-state current	Full sine wave;Tj=50°C			-	1	A
$I_{TSM}$	Non repetitive surge peak on-state current	full cycle, Tj initial= 25°C	F=50 Hz tp=20ms	-	8	A	
			F=60 Hz tp=16.7ms	-	8.5	A	
$I^2t$	$I^2t$ Value for fusing	$T_p=10ms$			-	0.35	A <sup>2</sup> S
DI/dt	Critical rate of rise of on-state current	$I_G=2x I_{GT}, tr<=100ns$	F=120Hz	Tj=125°C	-	20	A/μs
$I_{GM}$	Peak gate current		tp=20us	Tj=125°C	-	1	A
$I_{DRM}$	$V_{DRM}=V_{RRM}$			Tj=25°C	-	5	μA
$I_{RRM}$				Tj=125°C	-	0.5	mA
$P_{G(AV)}$	Average gate power			Tj=125°C	-	0.1	W
$T_{stg}$	Storage temperature range				-40	150	°C
$T_j$	Operating junction Temperature range				-40	125	°C

 **$T_j = 25^\circ C$  unless otherwise stated**

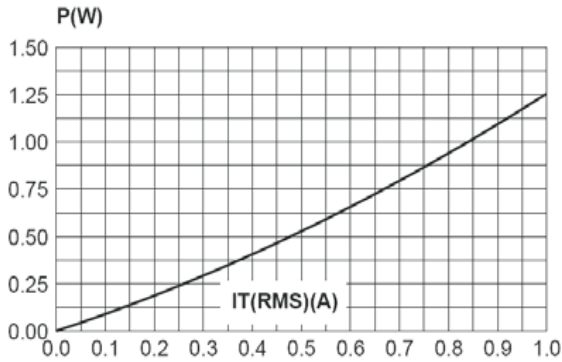
SYMBOL	PARAMETER	CONDITIONS			MIN	TYP	MAX	UNIT
Static characteristics								
$I_{GT1}$ $V_{GT}$		$V_D=12V; RL=33\Omega$	I-II-III IV ALL		-	-	3 5 1.3	mA mA V
$I_L$		$I_G=1.2 I_{GT}$	I-III-IV II		- -	- -	7 15	mA mA
$I_{H2}$		$I_T=50mA$			-	-	7	mA
$V_{GD}$		$V_D=V_{DRM} R_L=3.3K\Omega$	Tj=125°C	ALL	0.2	-	-	V
dV/dt2		$V_D=67\%V_{DRM}$	gate open;	Tj=110°C	10	-	-	V/μs
(Dv/dt)c(2)		(DI/dt)c=0.44A/ms;	Tj=110°C		0.5	-	-	V/μs

**Dynamic Characteristics**

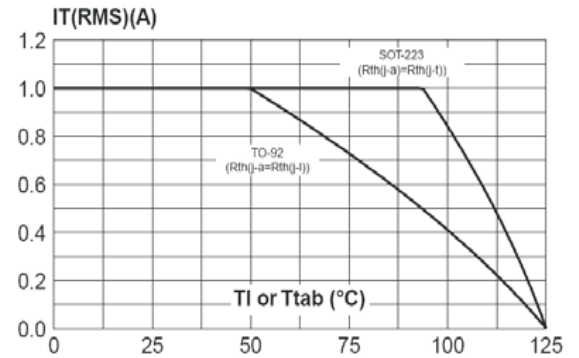
$V_{TM}(2)$	$I_{TM}=1.4A$ tp=380 μs	Tj=25°C				1.6	V
$V_{to}$ $R_d$	Threshold voltage Dynamic resistance	Tj=125°C Tj=125°C				0.95 400	V mΩ

## Description

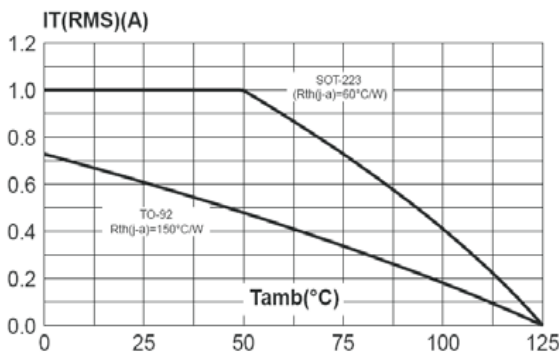
**Fig. 1:** Maximum power dissipation versus RMS on-state current (full cycle).



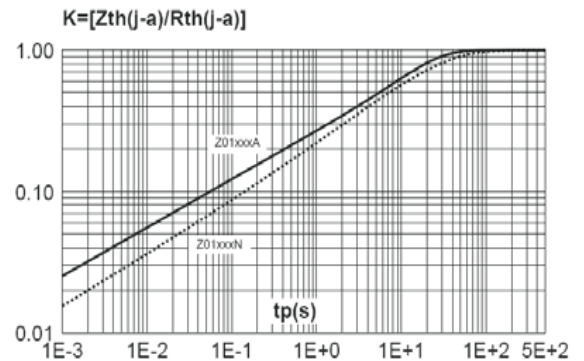
**Fig. 2-1:** RMS on-state current versus ambient temperature (full cycle).



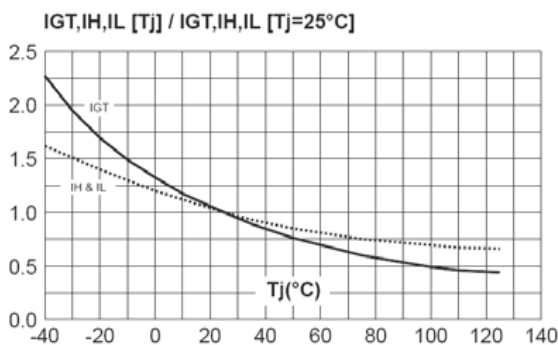
**Fig. 2-2:** RMS on-state current versus ambient temperature (full cycle).



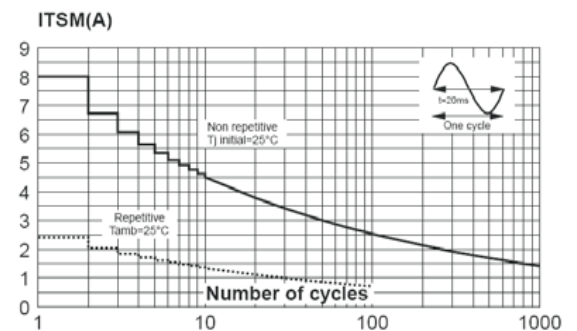
**Fig. 3:** Relative variation of thermal impedance junction to ambient versus pulse duration.



**Fig. 4:** Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).

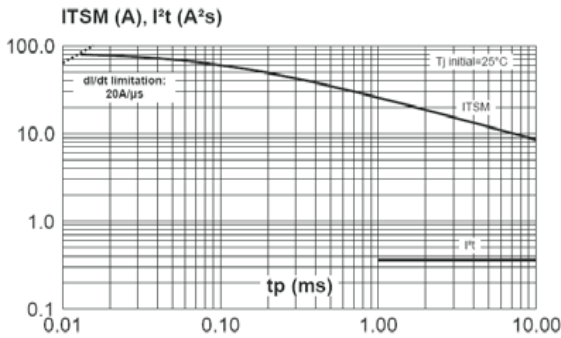


**Fig. 5:** Surge peak on-state current versus number of cycles.

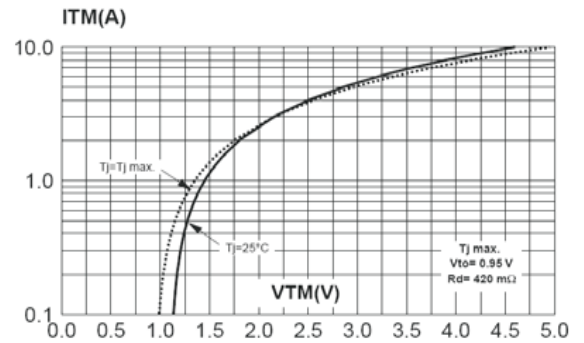


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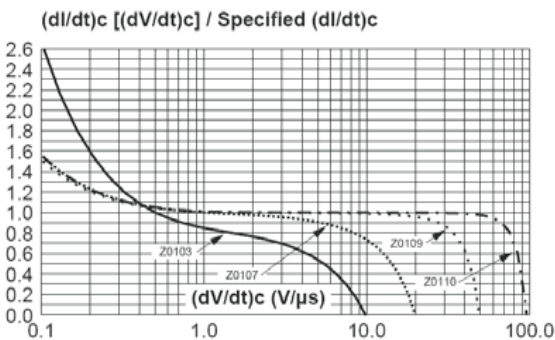
**Fig. 6:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$ .



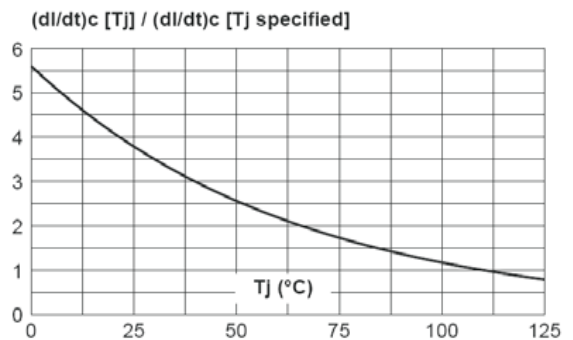
**Fig. 7:** On-state characteristics (maximum values).



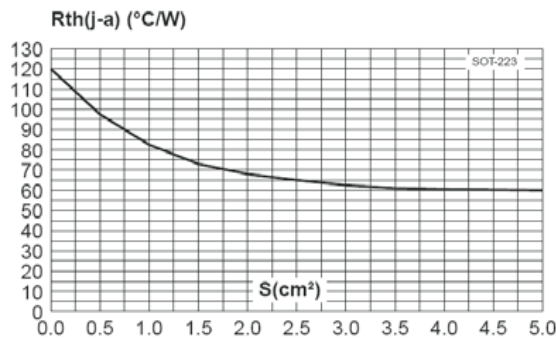
**Fig. 8:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values).



**Fig. 9:** Relative variation of critical rate of decrease of main current versus junction temperature.



**Fig. 10:** SOT-223 Thermal resistance junction to ambient versus copper surface under tab (printed circuit board FR4, copper thickness:  $35\mu\text{m}$ ).

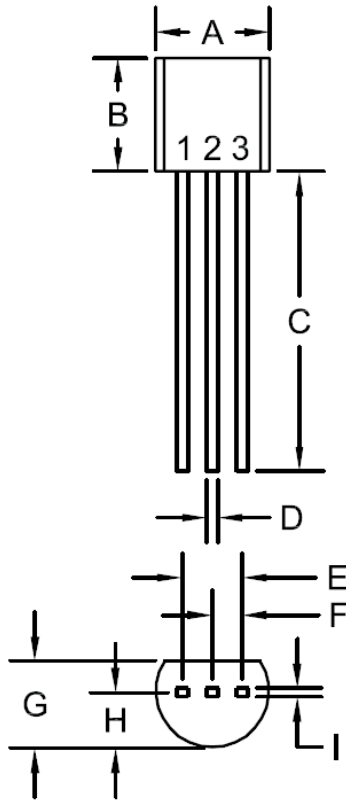


## Mechanical Data

Dimensions in mm

Net Mass:0.2 g

## TO-92



DIMENSIONS				
SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A (DIA)	0.175	0.205	4.45	5.21
B	0.170	0.210	4.32	5.33
C	0.500	-	12.70	-
D	0.016	0.022	0.41	0.56
E	0.100		2.54	
F	0.050		1.27	
G	0.125	0.165	3.18	4.19
H	0.080	0.105	2.03	2.67
I	0.015		0.38	